

# 74ALVT162245

16-bit transceiver with 30  $\Omega$  termination resistors; 3-state

Rev. 3 — 29 January 2018

Product data sheet

## 1 General description

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The 74ALVT162245 is a high-performance BiCMOS product designed for  $V_{CC}$  operation at 2.5 V or 3.3 V with I/O compatibility up to 5 V.

This device is a 16-bit transceiver featuring non-inverting 3-state bus compatible outputs in both send and receive directions. The control function implementation minimizes external timing requirements. The device features an output enable input ( $n\overline{OE}$ ) for easy cascading and a direction control input ( $nDIR$ ) for direction control.

The 74ALVT162245 is designed with 30  $\Omega$  series resistance in both the HIGH-state and LOW-state of the output. This design reduces line noise in applications such as memory address drivers, clock drivers and bus transceivers and transmitters.

## 2 Features and benefits

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- 16-bit bidirectional bus interface
- 3-State buffers
- 5V I/O compatible
- Output capability: +12 mA/-12 mA
- TTL input and output switching levels
- Input and output interface capability to systems at 5 V supply
- Bus-hold data inputs eliminate the need for external pull-up resistors to hold unused inputs
- Live insertion/extraction permitted
- Outputs include series resistance of 30  $\Omega$  making external termination resistors unnecessary
- Power-up 3-State
- No bus current loading when output is tied to 5 V bus
- Latch-up protection:
  - JESD17: exceeds 500 mA
- ESD protection:
  - MIL STD 883 method 3015: exceeds 2000 V
  - MM: exceeds 200 V

### 3 Ordering information

Table 1. Ordering information

Type number	Package		Description	Version
	Temperature range	Name		
74ALVT162245DL	-40 °C to +85 °C	SSOP48	plastic shrink small outline package; 48 leads; body width 7.5 mm	SOT370-1
74ALVT162245DGG	-40 °C to +85 °C	TSSOP48	plastic thin shrink small outline package; 48 leads; body width 6.1 mm	SOT362-1

### 4 Functional diagram

Table 2.

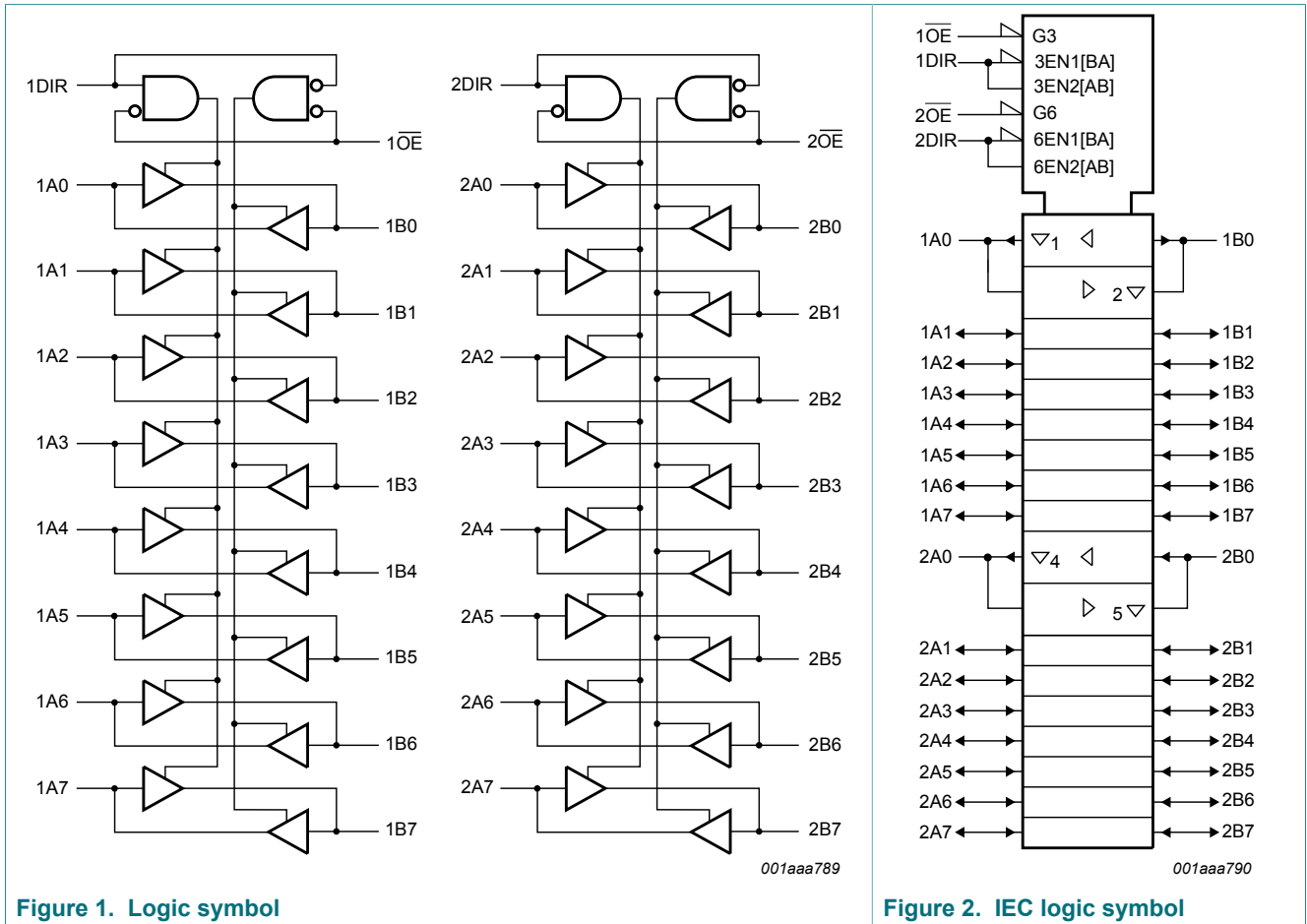


Figure 1. Logic symbol

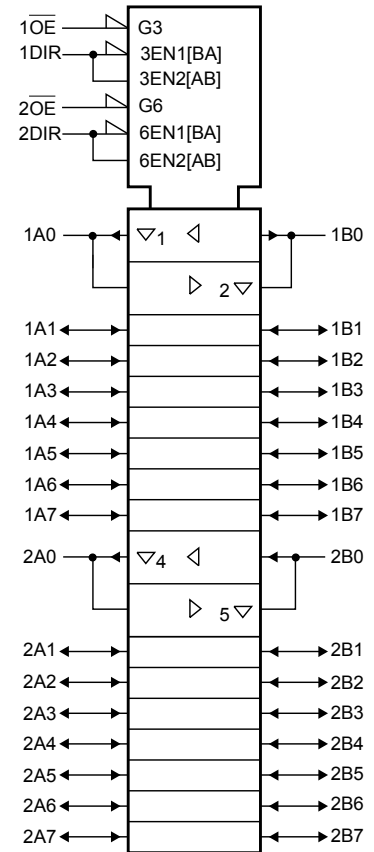


Figure 2. IEC logic symbol

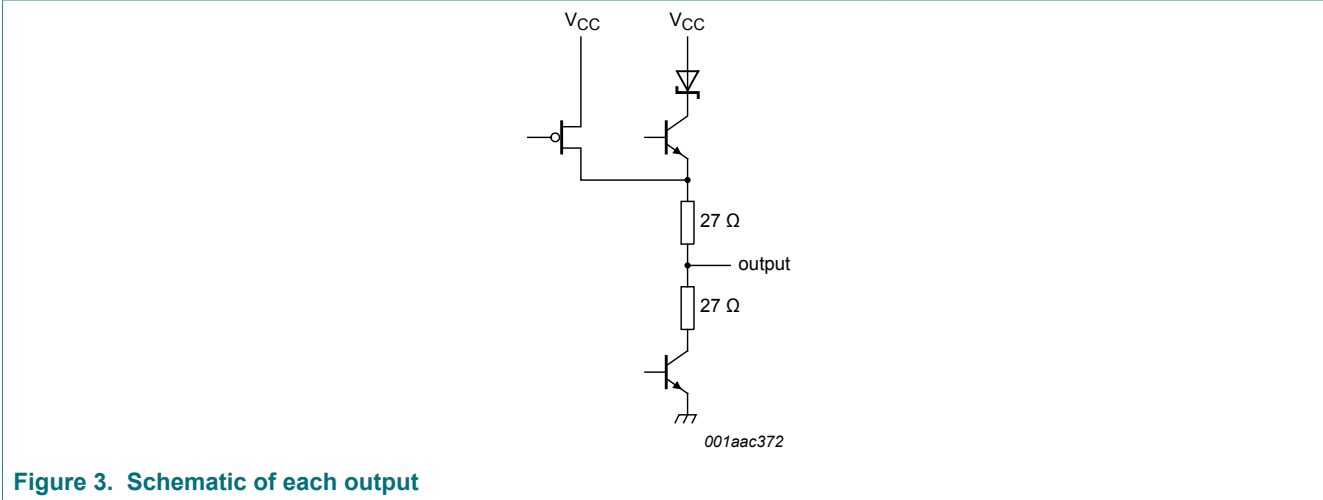


Figure 3. Schematic of each output

## 5 Pinning information

### 5.1 Pinning

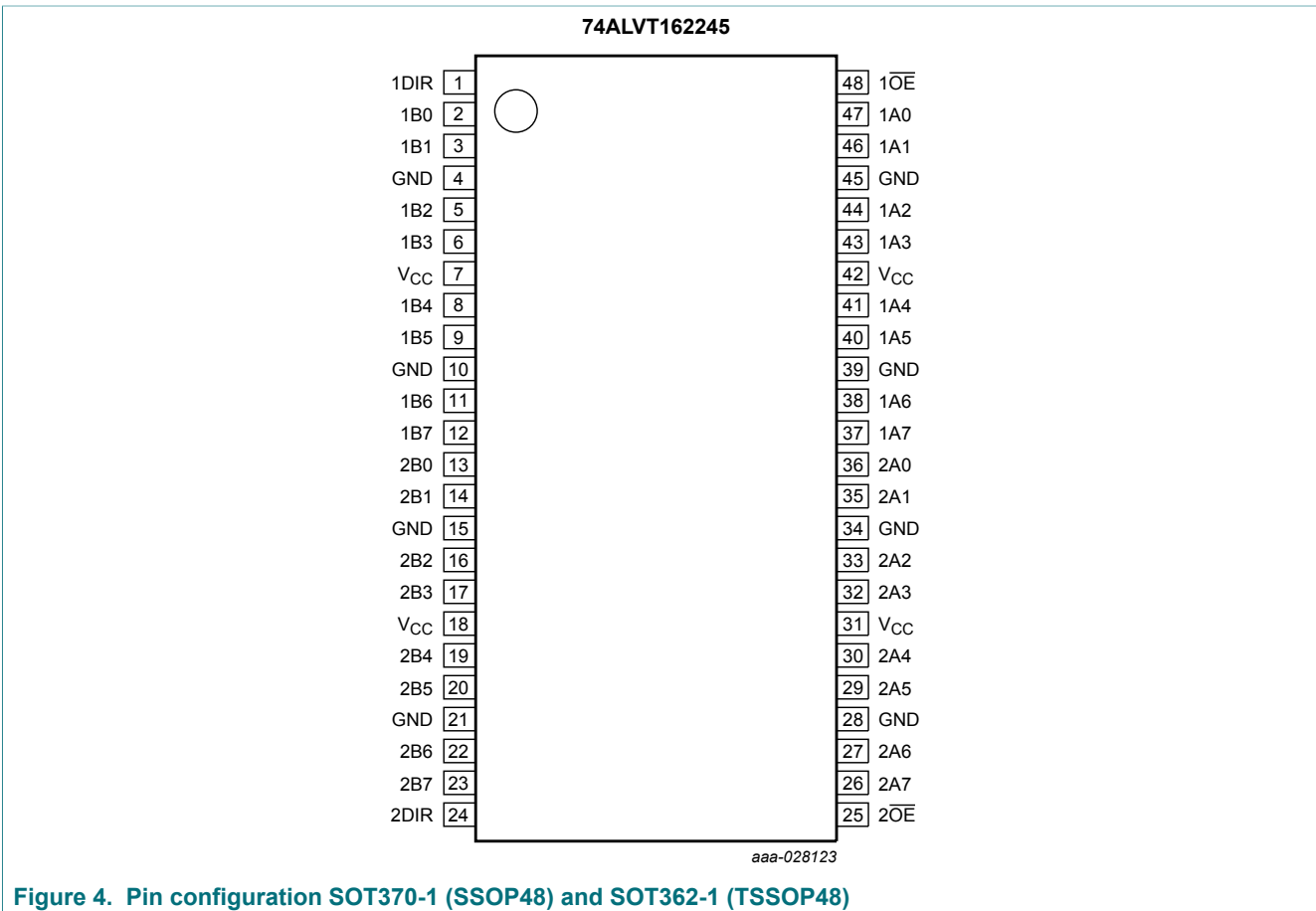


Figure 4. Pin configuration SOT370-1 (SSOP48) and SOT362-1 (TSSOP48)

## 5.2 Pin description

Table 3. Pin description

Symbol	Pin	Description
1DIR, 2DIR	1, 24	direction control input
1A0, 1A1, 1A2, 1A3, 1A4, 1A5, 1A6, 1A7	47, 46, 44, 43, 41, 40, 38, 37	data input/output
2A0, 2A1, 2A2, 2A3, 2A4, 2A5, 2A6, 2A7	36, 35, 33, 32, 30, 29, 27, 26	data input/output
GND	4, 10, 15, 21, 28, 34, 39, 45	ground (0 V)
1B0, 1B1, 1B2, 1B3, 1B4, 1B5, 1B6, 1B7	2, 3, 5, 6, 8, 9, 11, 12	data input/output
2B0, 2B1, 2B2, 2B3, 2B4, 2B5, 2B6, 2B7	13, 14, 16, 17, 19, 20, 22, 23	data input/output
1 $\overline{\text{OE}}$ , 2 $\overline{\text{OE}}$	48, 25	output enable input (active-LOW)
V <sub>CC</sub>	7, 18, 31, 42	supply voltage

## 6 Functional description

Table 4. Function table

*H = HIGH voltage level; L = LOW voltage level; X = don't care; Z = high-impedance OFF-state.*

Control		Input/output	
n $\overline{\text{OE}}$	nDIR	nAn	nBn
L	L	output nAn = nBn	input
L	H	input	output nBn = nAn
H	X	Z	Z

## 7 Limiting values

**Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CC}$	supply voltage		-0.5	+4.6	V
$V_I$	input voltage	[1]	-0.5	+7.0	V
$V_O$	output voltage	output in OFF-state or HIGH-state [1]	-0.5	+7.0	V
$I_{IK}$	input clamping current	$V_I < 0$ V	-50	-	mA
$I_{OK}$	output clamping current	$V_O < 0$ V	-50	-	mA
$I_O$	output current	output in LOW-state	-	128	mA
		output in HIGH-state	-64	-	mA
$T_{stg}$	storage temperature		-65	+150	$^{\circ}$ C
$T_j$	junction temperature	[2]	-	+150	$^{\circ}$ C

[1] The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

[2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability.

## 8 Recommended operating conditions

**Table 6. Recommended operating conditions**

Symbol	Parameter	Conditions	$V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$		$V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$		Unit
			Min	Max	Min	Max	
$V_{CC}$	supply voltage		2.3	2.7	3.0	3.6	V
$V_I$	input voltage		0	5.5	0	5.5	V
$I_{OH}$	HIGH-level output current		-	-8	-	-12	mA
$I_{OL}$	LOW-level output current		-	12	-	12	mA
$\Delta t/\Delta V$	input transition rise and fall rate	outputs enabled	-	10	-	10	ns/V
$T_{amb}$	ambient temperature	free-air	-40	+85	-40	+85	$^{\circ}$ C

## 9 Static characteristics

**Table 7. Static characteristics**

At recommended operating conditions;  $T_{amb} = -40\text{ }^{\circ}\text{C}$  to  $+85\text{ }^{\circ}\text{C}$ ; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Typ <sup>[1]</sup>	Max	Unit	
<b><math>V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}</math></b>							
$V_{IK}$	input clamping voltage	$V_{CC} = 2.3\text{ V}$ ; $I_{IK} = -18\text{ mA}$	-	-0.85	-1.2	V	
$V_{IH}$	HIGH-level input voltage	$V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$	1.7	-	-	V	
$V_{IL}$	LOW-level input voltage	$V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$	-	-	0.7	V	
$V_{OH}$	HIGH-level output voltage	$V_{CC} = 2.3\text{ V}$ ; $I_O = -8\text{ mA}$	1.7	-	-	V	
$V_{OL}$	LOW-level output voltage	$V_{CC} = 2.3\text{ V}$ ; $I_O = 12\text{ mA}$	-	0.6	0.7	V	
$I_I$	input leakage current	all input pins <sup>[2]</sup>					
		$V_{CC} = 0\text{ V}$ or $2.7\text{ V}$ ; $V_I = 5.5\text{ V}$	-	0.1	10	$\mu\text{A}$	
		control pins					
		$V_{CC} = 2.7\text{ V}$ ; $V_I = V_{CC}$ or GND	-	0.1	$\pm 1$	$\mu\text{A}$	
		I/O data pins <sup>[2]</sup>					
		$V_{CC} = 2.7\text{ V}$ ; $V_I = V_{CC}$	-	0.1	1	$\mu\text{A}$	
		$V_{CC} = 2.7\text{ V}$ ; $V_I = 0\text{ V}$	-	0.1	-5	$\mu\text{A}$	
$I_{OFF}$	power-off leakage current	$V_{CC} = 0\text{ V}$ ; $V_I$ or $V_O = 0\text{ V}$ to $4.5\text{ V}$	-	0.1	$\pm 100$	$\mu\text{A}$	
$I_{BHL}$	bus hold LOW current	data inputs; $V_{CC} = 2.3\text{ V}$ ; $V_I = 0.7\text{ V}$ <sup>[3]</sup>	-	90	-	$\mu\text{A}$	
$I_{BHH}$	bus hold HIGH current	data inputs; $V_{CC} = 2.3\text{ V}$ ; $V_I = 1.7\text{ V}$ <sup>[3]</sup>	-	-75	-	$\mu\text{A}$	
$I_{EX}$	external current	output in HIGH-state when $V_O > V_{CC}$ ; $V_O = 5.5\text{ V}$ ; $V_{CC} = 2.3\text{ V}$	-	20	125	$\mu\text{A}$	
$I_{O(pu/pd)}$	power-up/power-down output current	$V_{CC} \leq 1.2\text{ V}$ ; $V_O = 0.5\text{ V}$ to $V_{CC}$ ; $V_I = \text{GND}$ or $V_{CC}$ ; $nOE = \text{don't care}$ <sup>[4]</sup>	-	40	100	$\mu\text{A}$	
$I_{CC}$	supply current	$V_{CC} = 2.7\text{ V}$ ; $V_I = \text{GND}$ or $V_{CC}$ ; $I_O = 0\text{ A}$					
		outputs HIGH	-	0.04	0.1	mA	
		outputs LOW	-	2.5	4.5	mA	
		outputs disabled <sup>[5]</sup>	-	0.04	0.1	mA	
$\Delta I_{CC}$	additional supply current	per input pin; $V_{CC} = 2.3\text{ V}$ to $2.7\text{ V}$ ; one input at $V_{CC} - 0.6\text{ V}$ ; other inputs at $V_{CC}$ or GND <sup>[6]</sup>	-	0.05	0.4	mA	
$C_I$	input capacitance	nDIR and $nOE$ ; $V_I = 0\text{ V}$ or $V_{CC}$	-	3	-	pF	
$C_{I/O}$	input/output capacitance	$V_{I/O} = 0\text{ V}$ or $V_{CC}$	-	9	-	pF	

Symbol	Parameter	Conditions	Min	Typ <sup>[1]</sup>	Max	Unit
<b>V<sub>CC</sub> = 3.3 V ± 0.3 V</b>						
V <sub>IK</sub>	input clamping voltage	V <sub>CC</sub> = 3.0 V; I <sub>IK</sub> = -18 mA	-	-0.85	-1.2	V
V <sub>IH</sub>	HIGH-level input voltage	V <sub>CC</sub> = 3.3 V ± 0.3 V	2.0	-	-	V
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 3.3 V ± 0.3 V	-	-	0.8	V
V <sub>OH</sub>	HIGH-level output voltage	V <sub>CC</sub> = 3.0 V; I <sub>O</sub> = -12 mA	2.0	2.3	-	V
V <sub>OL</sub>	LOW-level output voltage	V <sub>CC</sub> = 3.0 V; I <sub>O</sub> = 12 mA	-	0.6	0.8	V
I <sub>I</sub>	input leakage current	all input pins <sup>[2]</sup>				
		V <sub>CC</sub> = 0 V or 3.6 V; V <sub>I</sub> = 5.5 V	-	0.1	10	μA
		control pins				
		V <sub>CC</sub> = 3.6 V; V <sub>I</sub> = V <sub>CC</sub> or GND	-	0.1	±1	μA
		I/O data pins <sup>[2]</sup>				
		V <sub>CC</sub> = 3.6 V; V <sub>I</sub> = V <sub>CC</sub>	-	0.5	1	μA
		V <sub>CC</sub> = 3.6 V; V <sub>I</sub> = 0 V	-	0.1	-5	μA
I <sub>OFF</sub>	power-off leakage current	V <sub>CC</sub> = 0 V; V <sub>I</sub> or V <sub>O</sub> = 0 V to 4.5 V	-	0.1	±100	μA
I <sub>BHL</sub>	bus hold LOW current	data inputs; V <sub>CC</sub> = 3 V; V <sub>I</sub> = 0.8 V	75	130	-	μA
I <sub>BHH</sub>	bus hold HIGH current	data inputs; V <sub>CC</sub> = 3 V; V <sub>I</sub> = 2.0 V	-75	-140	-	μA
I <sub>BHLO</sub>	bus hold LOW overdrive current	data inputs; V <sub>CC</sub> = 3.6 V; V <sub>I</sub> = 0 V to 3.6 V <sup>[7]</sup>	500	-	-	μA
I <sub>BHHO</sub>	bus hold HIGH overdrive current	data inputs; V <sub>CC</sub> = 3.6 V; V <sub>I</sub> = 0 V to 3.6 V <sup>[7]</sup>	-500	-	-	μA
I <sub>EX</sub>	external current	output in HIGH-state when V <sub>O</sub> > V <sub>CC</sub> ; V <sub>O</sub> = 5.5 V; V <sub>CC</sub> = 3.0 V	-	50	125	μA
I <sub>O(pu/pd)</sub>	power-up/power-down output current	V <sub>CC</sub> ≤ 1.2 V; V <sub>O</sub> = 0.5 V to V <sub>CC</sub> ; V <sub>I</sub> = GND or V <sub>CC</sub> ; n $\overline{OE}$ = don't care <sup>[8]</sup>	-	40	±100	μA
I <sub>CC</sub>	supply current	V <sub>CC</sub> = 3.6 V; V <sub>I</sub> = GND or V <sub>CC</sub> ; I <sub>O</sub> = 0 A				
		outputs HIGH	-	0.07	0.1	mA
		outputs LOW	-	3.5	5	mA
		outputs disabled <sup>[5]</sup>	-	0.07	0.1	mA
ΔI <sub>CC</sub>	additional supply current	per input pin; V <sub>CC</sub> = 3 V to 3.6 V; one input at V <sub>CC</sub> - 0.6 V; other inputs at V <sub>CC</sub> or GND <sup>[6]</sup>	-	0.04	0.4	mA
C <sub>I</sub>	input capacitance	nDIR and n $\overline{OE}$ ; V <sub>I</sub> = 0 V or V <sub>CC</sub>	-	3	-	pF
C <sub>I/O</sub>	input/output capacitance	V <sub>I/O</sub> = 0 V or V <sub>CC</sub>	-	9	-	pF

[1] Typical values for V<sub>CC</sub> = 2.3 V to 2.7 V are measured at V<sub>CC</sub> = 2.5 V and T<sub>amb</sub> = 25 °C.  
 Typical values for V<sub>CC</sub> = 3.0 V to 3.6 V are measured at V<sub>CC</sub> = 3.3 V and T<sub>amb</sub> = 25 °C.  
 [2] Unused pins at V<sub>CC</sub> or GND.  
 [3] Not guaranteed.  
 [4] This parameter is valid for any V<sub>CC</sub> between 0 V and 1.2 V with a transition time of up to 10 ms.  
 From V<sub>CC</sub> = 1.2 V to V<sub>CC</sub> = 2.5 V ± 0.2 V a transition time of 100 μs is permitted. This parameter is valid for T<sub>amb</sub> = 25 °C only.  
 [5] I<sub>CC</sub> with outputs disabled is measured with outputs pulled to V<sub>CC</sub> or GND.  
 [6] This is the increase in supply current for each input at the specified voltage level other than V<sub>CC</sub> or GND.  
 [7] This is the bus hold overdrive current required to force the input to the opposite logic state.  
 [8] This parameter is valid for any V<sub>CC</sub> between 0 V and 1.2 V with a transition time of up to 10 ms.  
 From V<sub>CC</sub> = 1.2 V to V<sub>CC</sub> = 3.0 V ± 0.3 V a transition time of 100 μs is permitted. This parameter is valid for T<sub>amb</sub> = 25 °C only.

## 10 Dynamic characteristics

**Table 8. Dynamic characteristics**

Voltages are referenced to GND (ground = 0 V);  $T_{amb} = -40\text{ }^{\circ}\text{C}$  to  $+85\text{ }^{\circ}\text{C}$ ; for test circuit see [Figure 7](#).

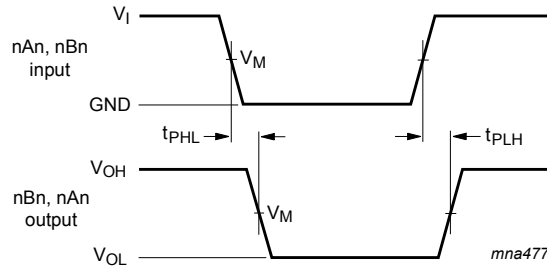
Symbol	Parameter	Conditions	Min	Typ <sup>[1]</sup>	Max	Unit
<b><math>V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}</math></b>						
$t_{PLH}$	LOW to HIGH propagation delay	nAn to nBn or nBn to nAn; see <a href="#">Figure 5</a>	1.5	2.9	5.3	ns
$t_{PHL}$	HIGH to LOW propagation delay	nAn to nBn or nBn to nAn; see <a href="#">Figure 5</a>	1.5	2.4	4.7	ns
$t_{PZH}$	OFF-state to HIGH propagation delay	$\overline{nOE}$ to nAn or $\overline{nOE}$ to nBn; see <a href="#">Figure 6</a>	1.5	4.3	6.3	ns
$t_{PZL}$	OFF-state to LOW propagation delay	$\overline{nOE}$ to nAn or $\overline{nOE}$ to nBn; see <a href="#">Figure 6</a>	1.5	3.1	4.6	ns
$t_{PHZ}$	HIGH to OFF-state propagation delay	$\overline{nOE}$ to nAn or $\overline{nOE}$ to nBn; see <a href="#">Figure 6</a>	1.5	4.2	6.2	ns
$t_{PLZ}$	LOW to OFF-state propagation delay	$\overline{nOE}$ to nAn or $\overline{nOE}$ to nBn; see <a href="#">Figure 6</a>	1.5	3.3	5.1	ns
<b><math>V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}</math></b>						
$t_{PLH}$	LOW to HIGH propagation delay	nAn to nBn or nBn to nAn; see <a href="#">Figure 5</a>	0.5	2.3	3.6	ns
$t_{PHL}$	HIGH to LOW propagation delay	nAn to nBn or nBn to nAn; see <a href="#">Figure 5</a>	0.5	2.0	3.1	ns
$t_{PZH}$	OFF-state to HIGH propagation delay	$\overline{nOE}$ to nAn or $\overline{nOE}$ to nBn; see <a href="#">Figure 6</a>	1.0	3.0	5.0	ns
$t_{PZL}$	OFF-state to LOW propagation delay	$\overline{nOE}$ to nAn or $\overline{nOE}$ to nBn; see <a href="#">Figure 6</a>	1.0	2.6	3.9	ns
$t_{PHZ}$	HIGH to OFF-state propagation delay	$\overline{nOE}$ to nAn or $\overline{nOE}$ to nBn; see <a href="#">Figure 6</a>	1.0	3.6	5.2	ns
$t_{PLZ}$	LOW to OFF-state propagation delay	$\overline{nOE}$ to nAn or $\overline{nOE}$ to nBn; see <a href="#">Figure 6</a>	1.0	3.0	4.6	ns

[1] Typical values for  $V_{CC} = 2.3\text{ V}$  to  $2.7\text{ V}$  are measured at  $V_{CC} = 2.5\text{ V}$  and  $T_{amb} = 25\text{ }^{\circ}\text{C}$ .

Typical values for  $V_{CC} = 3.0\text{ V}$  to  $3.6\text{ V}$  are measured at  $V_{CC} = 3.3\text{ V}$  and  $T_{amb} = 25\text{ }^{\circ}\text{C}$ .



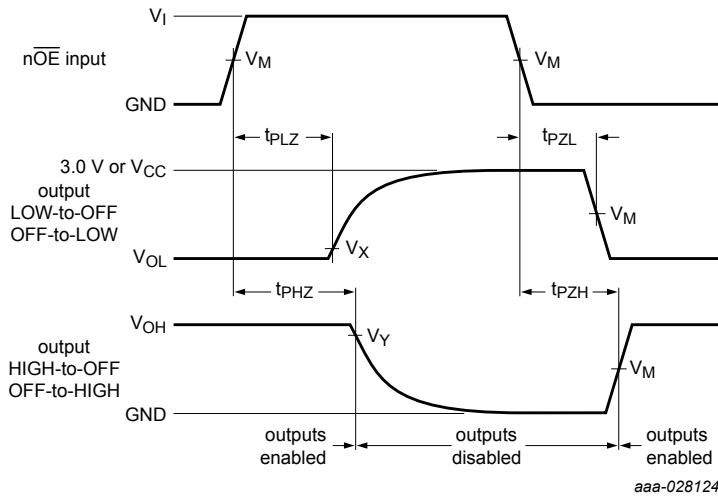
10.1 Waveforms and test circuit



Measurement points are given in [Table 9](#).

$V_{OL}$  and  $V_{OH}$  are typical voltage output levels that occur with the output load.

Figure 5. Input (nAn or nBn) to output (nBn or nAn) propagation delays



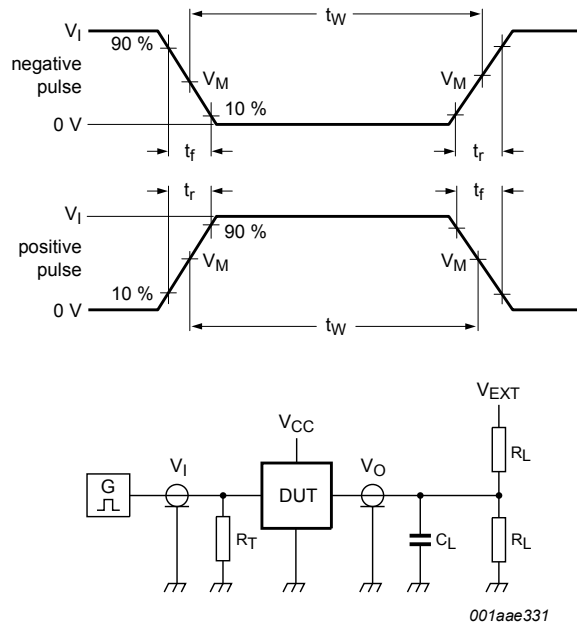
Measurement points are given in [Table 9](#).

$V_{OL}$  and  $V_{OH}$  are typical voltage output levels that occur with the output load.

Figure 6. 3-state output enable and disable times

Table 9. Measurement points

$V_{CC}$	Input		Output		
	$V_I$	$V_M$	$V_M$	$V_X$	$V_Y$
$V_{CC} \leq 2.7 \text{ V}$	$V_{CC}$	$0.5 \times V_{CC}$	$0.5 \times V_{CC}$	$V_{OL} + 0.1 \text{ V}$	$V_{OH} - 0.1 \text{ V}$
$V_{CC} \geq 3.0 \text{ V}$	3.0 V	1.5 V	1.5 V	$V_{OL} + 0.3 \text{ V}$	$V_{OH} - 0.3 \text{ V}$



Test data is given in [Table 10](#).

Definitions test circuit:

$R_L$  = Load resistance.

$C_L$  = Load capacitance including jig and probe capacitance.

$R_T$  = Termination resistance should be equal to output impedance  $Z_o$  of the pulse generator.

$V_{EXT}$  = Test voltage for switching times.

**Figure 7. Test circuit for measuring switching times**

**Table 10. Test data**

Input			Load			$V_{EXT}$		
$V_I$	$f_i$	$t_W$	$t_r, t_f$	$C_L$	$R_L$	$t_{PHZ}, t_{PZH}$	$t_{PLZ}, t_{PZL}$	$t_{PLH}, t_{PHL}$
3.0 V or $V_{CC}$ whichever is less	$\leq 10$ MHz	500 ns	$\leq 2.5$ ns	50 pF	500 Ω	GND	6 V or $V_{CC} \times 2$	open

11 Package outline

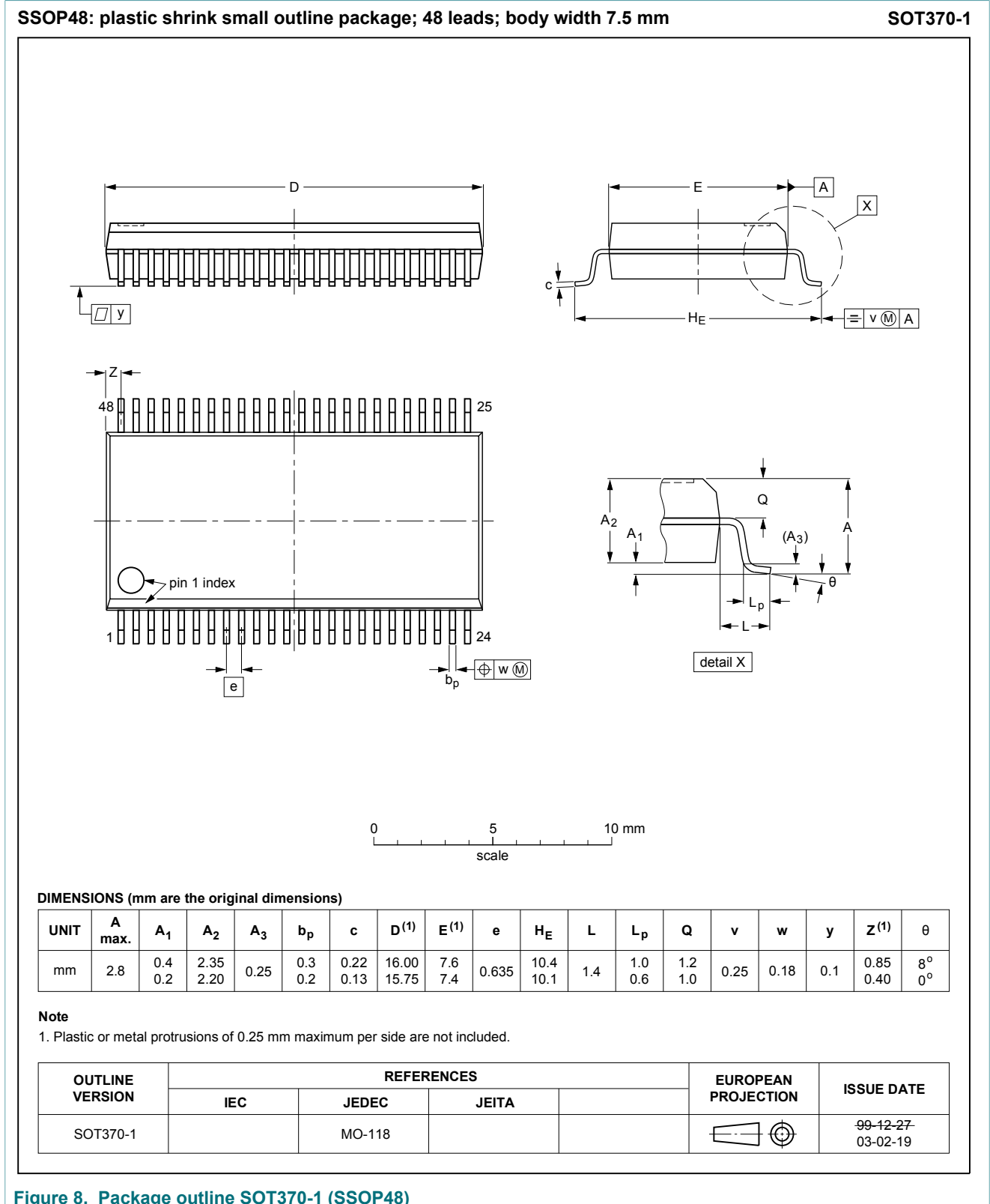


Figure 8. Package outline SOT370-1 (SSOP48)

TSSOP48: plastic thin shrink small outline package; 48 leads; body width 6.1 mm

SOT362-1



Dimensions (mm are the original dimensions)

Unit	A	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	b <sub>p</sub>	c	D <sup>(1)</sup>	E <sup>(2)</sup>	e	H <sub>E</sub>	L	L <sub>p</sub>	Q	v	w	y	Z	θ
max		0.15	1.05		0.28	0.2	12.6	6.2		8.3		0.8	0.50				0.8	8°
nom	1.2			0.25					0.5		1			0.25	0.08	0.1		
min		0.05	0.85		0.17	0.1	12.4	6.0		7.9		0.4	0.35				0.4	0°

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

sot362-1\_po

Outline version	References				European projection	Issue date
	IEC	JEDEC	JEITA			
SOT362-1		MO-153				03-02-19 13-08-05

Figure 9. Package outline SOT362-1 (TSSOP48)

## 12 Abbreviations

Table 11. Abbreviations

Acronym	Description
BICMOS	Bipolar Complementary Metal Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
MIL	Military
MM	Machine Model
TTL	Transistor-Transistor Logic

## 13 Revision history

Table 12. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74ALVT162245 v.3	20180129	Product data sheet	-	74ALVT162245 v.2
Modifications:	<ul style="list-style-type: none"> <li>The format of this data sheet has been redesigned to comply with the identity guidelines of Nexperia.</li> <li>Legal texts have been adapted to the new company name where appropriate.</li> </ul>			
74ALVT162245 v.2	19980213	Product specification	-	74ALVT162245 v.1
74ALVT162245 v.1	19960305	Product specification	-	-

## 14 Legal information

### 14.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nexperia.com>.

### 14.2 Definitions

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## Contents

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<b>1</b>	<b>General description .....</b>	<b>1</b>
<b>2</b>	<b>Features and benefits .....</b>	<b>1</b>
<b>3</b>	<b>Ordering information .....</b>	<b>2</b>
<b>4</b>	<b>Functional diagram .....</b>	<b>2</b>
<b>5</b>	<b>Pinning information .....</b>	<b>3</b>
5.1	Pinning .....	3
5.2	Pin description .....	4
<b>6</b>	<b>Functional description .....</b>	<b>4</b>
<b>7</b>	<b>Limiting values .....</b>	<b>5</b>
<b>8</b>	<b>Recommended operating conditions .....</b>	<b>5</b>
<b>9</b>	<b>Static characteristics .....</b>	<b>6</b>
<b>10</b>	<b>Dynamic characteristics .....</b>	<b>8</b>
10.1	Waveforms and test circuit .....	9
<b>11</b>	<b>Package outline .....</b>	<b>11</b>
<b>12</b>	<b>Abbreviations .....</b>	<b>13</b>
<b>13</b>	<b>Revision history .....</b>	<b>13</b>
<b>14</b>	<b>Legal information .....</b>	<b>14</b>

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For sales office addresses, please send an email to: [salesaddresses@nexperia.com](mailto:salesaddresses@nexperia.com)

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